



GL290N04A8

GL Silicon N-Channel Power MOSFET

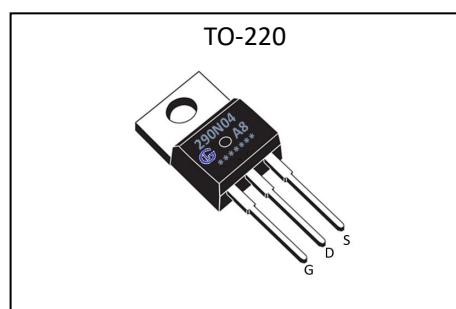
General Description

The GL290N04A8 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications. The package form is TO-220AB, which accords with the RoHS standard.

V_{DSS}	40	V
I_D	290	A
P_D	242	W
$R_{DS(ON)type}$	1.6	m Ω

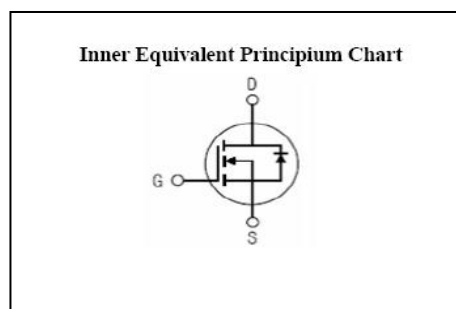
Features

- $R_{DS(ON)} < 2.3m\Omega$ @ $V_{GS}=10V$ (Typ1.6m Ω)
- High density cell design for ultra low R_{dson}
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation



Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Absolute (Tc= 25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	40	V
I_D	Continuous Drain Current (Silicon Limited)	290	
	Continuous Drain Current(Package Limited)	80	A
I_{DM}	Pulsed Drain Current	1160	A
V_{GS}	Gate-to-Source Voltage	± 20	V
P_D	Power Dissipation	250	W
E_{AS}	Single pulse avalanche energy	1300	mJ
T_J, T_{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175	$^{\circ}C$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case ^{a2}	0.60	$^{\circ}C/W$



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Electrical Characteristics (Tc= 25°C unless otherwise specified)

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	40	--	--	V
I _{DSS}	Drain to Source Leakage Current	V _{DS} =32V, V _{GS} = 0V, T _a =25°C	--	--	1.0	μA
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} = +20V	--	--	0.1	μA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} = -20V	--	--	-0.1	μA

ON Characteristics ^{a3}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =10V, I _D =80A	--	1.6	2.3	mΩ
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.0	--	4.0	V
Pulse width tp≤380μs, δ≤2%						

Dynamic Characteristics ^{a4}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V f=1.0MHz	--	8400	--	pF
C _{oss}	Output Capacitance		--	1180	--	
C _{rss}	Reverse Transfer Capacitance		--	630	--	

Resistive Switching Characteristics ^{a4}						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =20V, I _D =80A V _{GS} =10V, R _G =1.6Ω, R _L =0.5Ω	--	30	--	ns
t _r	Rise Time		--	81	--	
t _{d(OFF)}	Turn-Off Delay Time		--	185	--	
t _f	Fall Time		--	91	--	
Q _g	Total Gate Charge	V _{DD} =20V, I _D =850A V _{GS} =10V	--	135	--	nC
Q _{gs}	Gate to Source Charge		--	36.0	--	
Q _{gd}	Gate to Drain ("Miller") Charge		--	23.5	--	



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Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t_{rr}	Reverse Recovery Time	$I_S=80A, T_j=25^{\circ}C$	--	70	--	ns
Q_{rr}	Reverse Recovery Charge	$di_F/dt=100A/\mu s, V_{GS}=0V$	--	67	--	μC
I_S	Continuous Source Current ^{a2} (Body Diode)		--	--	80	A
V_{SD}	Diode Forward Voltage ^{a3}	$I_S=80A, V_{GS}=0V$	--	--	1.2	V

^{a1}: Repetitive Rating: Pulse width limited by maximum junction temperature.

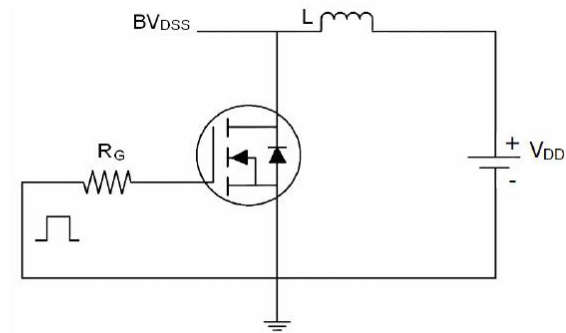
^{a2}: Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.

^{a3}: Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

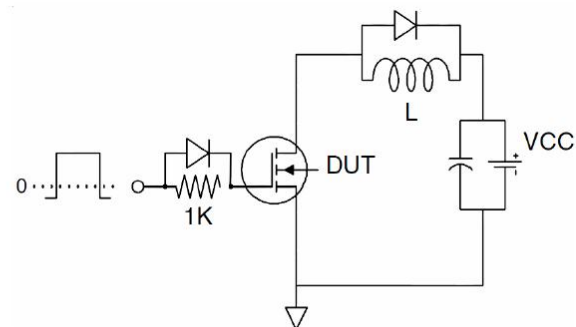
^{a4}: Guaranteed by design, not subject to production

Test Circuits

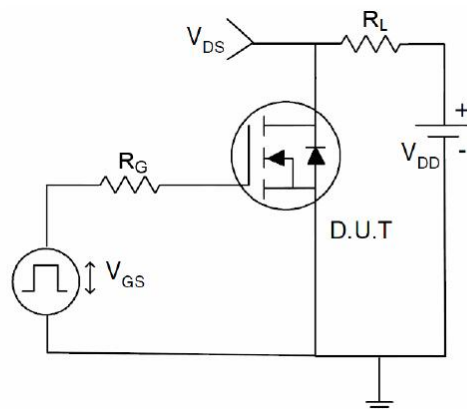
1) EAS test Circuit



2) Gate charge test Circuit

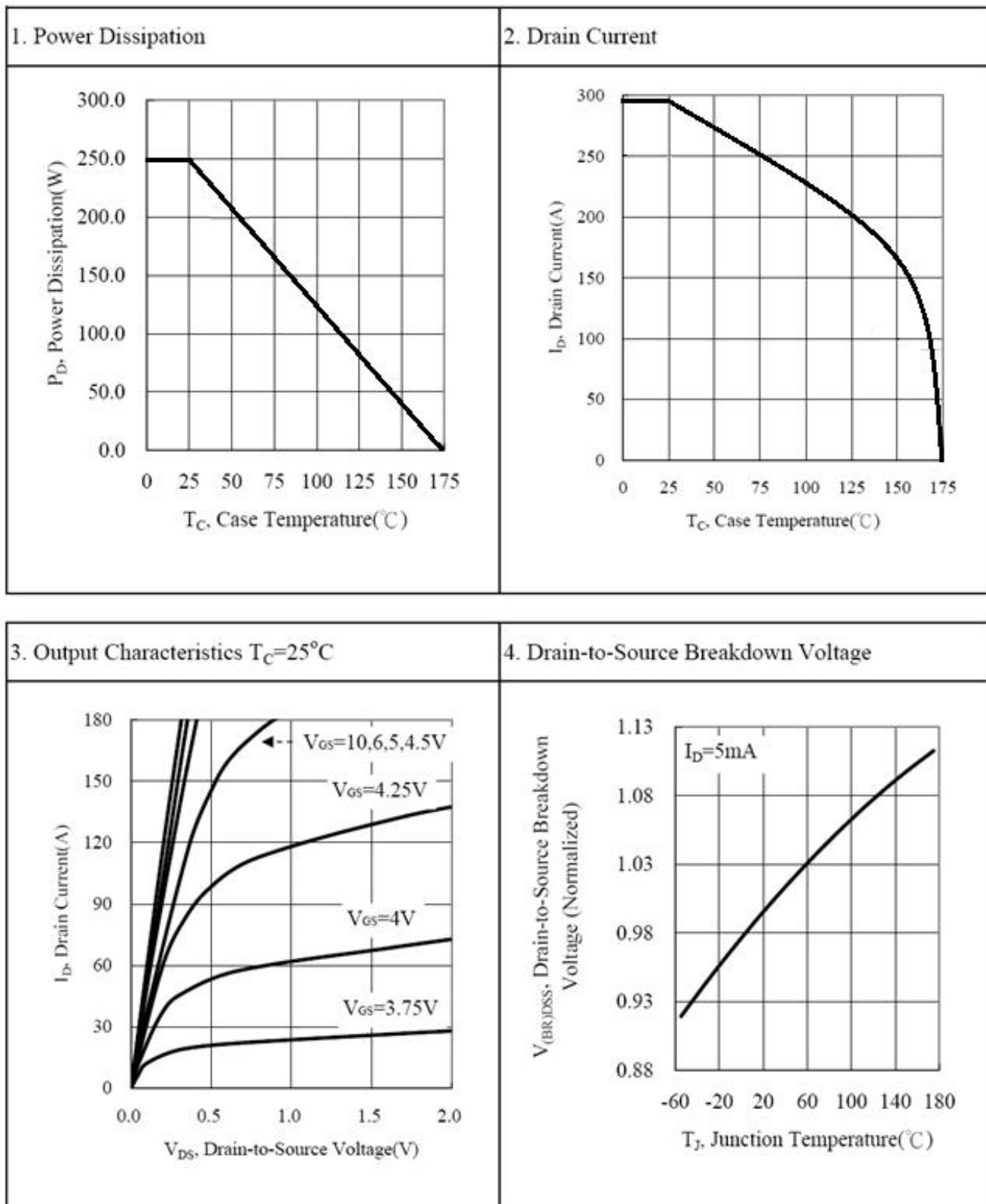


3) Switch Time Test Circuit

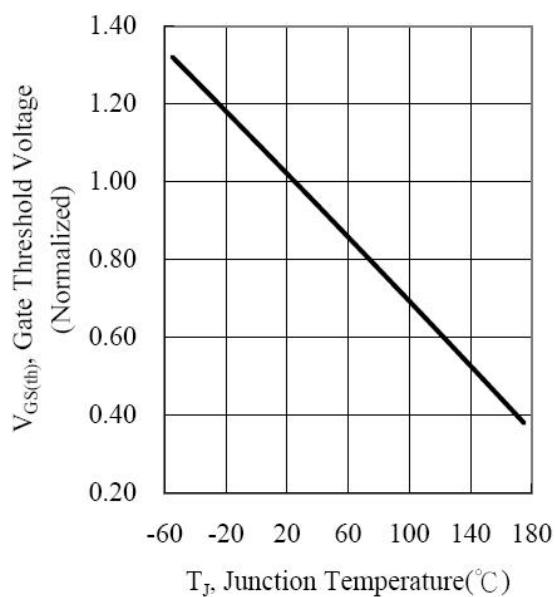


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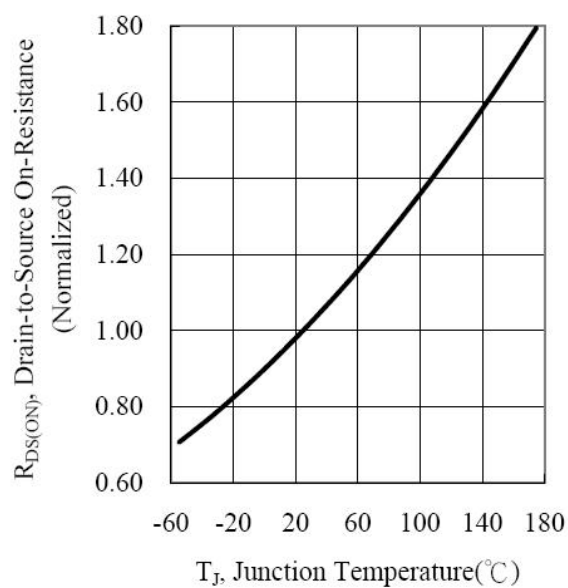
Characteristics Curves



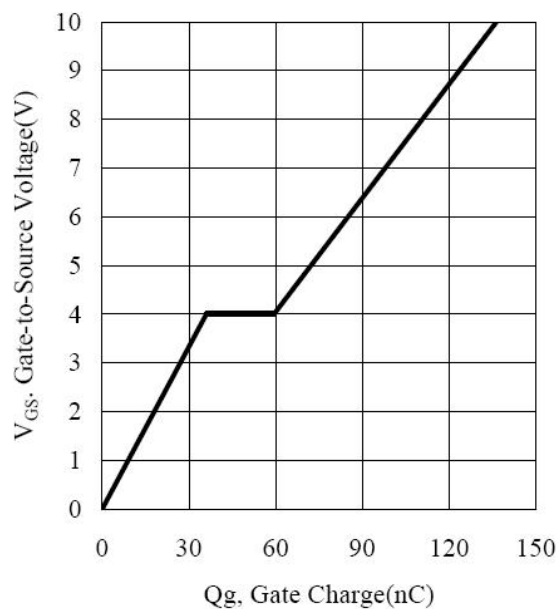
5. Gate Threshold Voltage



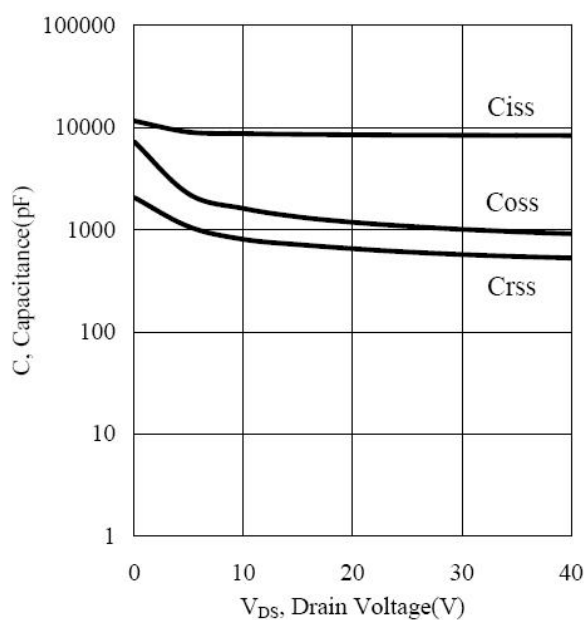
6. Drain-to-Source On-Resistance



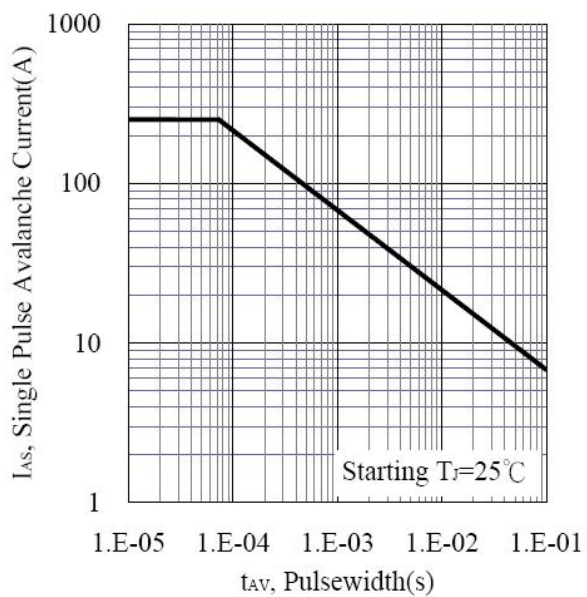
7. Typ. Gate Charge



8. Typ. Capacitance



9. Avalanche Characteristics



10. Forward Characteristics of reverse diode

